

<b>Notice of References Cited</b>	Application/Control No. 10/826,391	Applicant(s)/Patent Under Reexamination TAKAHASHI ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-5,270,230	12-1993	Sakurai, Kenya	438/141
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